

INFORMATION DISCLOSURE
CITATION

ATTY. DOCKET NO.

SERIAL NO.

4105-74

10/568,943

APPLICANT

CHO et al.

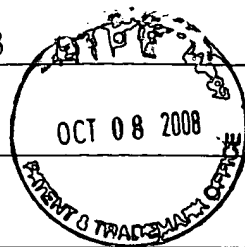
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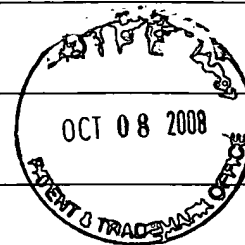
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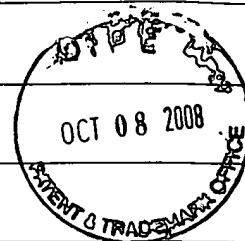
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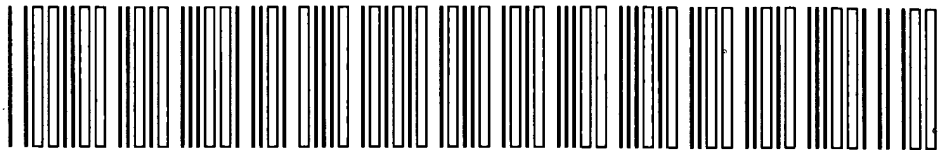
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